

• General Description

The AGM1030AP combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$.

This device is ideal for load switch and battery protection applications.

Features

- Advance high cell density Trench technology
- Low R_{DS(ON)} to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance
- 100% Avalanche tested
- 100% DVDS tested

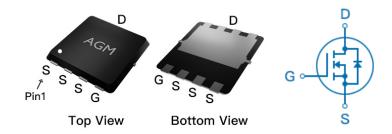
Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Product Summary

BVDSS	RDSON	ID
100V	26mΩ	20A

PDFN3.3*3.3 Pin Configuration



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM1030AP	AGM1030AP	PDFN3.3*3.3	330mm	12mm	5000

Table 1. Absolute Maximum Ratings (TA=25℃)

Symbol	Parameter	Value	Unit
VDS	Drain-Source Voltage (VGS=0V)	100	V
VGS	Gate-Source Voltage (VDS=0V)	±20	V
ID	Drain Current-Continuous(Tc=25℃) (Note 1)	20	Α
	Drain Current-Continuous(Tc=100℃)	14	А
IDM (pluse)	Drain Current-Pulsed (Note 2)	80	Α
PD	Maximum Power Dissipation(Tc=25℃)	26	W
	Maximum Power Dissipation(Tc=100℃)	10	W
EAS	Avalanche energy (Note 3)	26	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	$^{\circ}$

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
RθJA	Thermal Resistance Junction-ambient (Steady State) ¹		50	°C/W
RθJC	Thermal Resistance Junction-Case ¹		4.9	°C/W



Table 3. Electrical Characteristics (TJ=25°C unless otherwise noted)

le 3. Electrical Characteristics (TJ=25°C unless otherwise noted) mbol Parameter Conditions Min Typ Max Unit					
Parameter	Conditions	Min	Тур	Max	Unit
ates					
Drain-Source Breakdown Voltage	VGS=0V ID=250µA	100			V
Zero Gate Voltage Drain Current	VDS=100V,VGS=0V			1	μΑ
Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
Gate Threshold Voltage	VDS=VGS,ID=250µA	1.2		2.2	V
Forward Transconductance	VDS=5V,ID=8A		5		S
Drain-Source On-State Resistance	VGS=10V, ID=10A		26	32	mΩ
	VGS=4.5V, ID=8A		33	40	mΩ
Characteristics					
Input Capacitance			445		pF
Output Capacitance	VDS=40V,VGS=0V, F=1MHZ		171		pF
Reverse Transfer Capacitance			6.1		pF
Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		4.9		Ω
Times					
Turn-on Delay Time			12		nS
Turn-on Rise Time	ID=10A,VDS=50V		15		nS
Turn-Off Delay Time	VGS=10V ,RG=5 Ω		20		nS
Turn-Off Fall Time			6.0		nS
Total Gate Charge			8.0		nC
Gate-Source Charge	VGS=10V, VDS=50V,		1.4		nC
Gate-Drain Charge	10-100		1.84		nC
rain Diode Characteristics		'			1
Source-Drain Current(Body Diode)				20	Α
Forward on Voltage	VGS=0V,IS=10A			1.2	V
Reverse Recovery Time	V _{DD} =50V,Isd=10A ,		37		ns
Reverse Recovery Charge	dl/dt=100A/μs , TJ=25℃		80		nc
	Parameter Intes Drain-Source Breakdown Voltage Zero Gate Voltage Drain Current Gate-Body Leakage Current Gate Threshold Voltage Forward Transconductance Drain-Source On-State Resistance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate resistance Times Turn-on Delay Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge rain Diode Characteristics Source-Drain Current(Body Diode) Forward on Voltage Reverse Recovery Time	Parameter Conditions	Parameter Conditions Min Intes Intes Intes Intes Intes Intes Intes Intes Intes Intes Intes Intes Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter Inter	Parameter Conditions Min Typ	Parameter Conditions Min Typ Max

Notes 1. The maximum current rating is package limited.

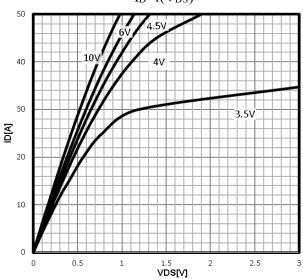
Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature.

Notes 3.EAS condition: TJ=25 $^{\circ}\text{C}$,VDD=50V,Vgs=10V,ID=23A.L=0.1mH,RG=25ohm

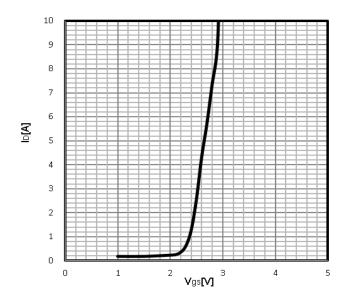


Characteristics Curve:

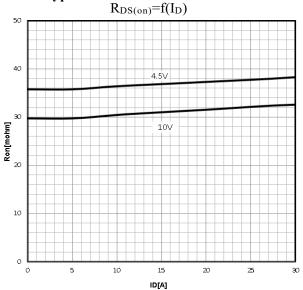
Typ. output characteristics $I_D = f(V_{DS})$



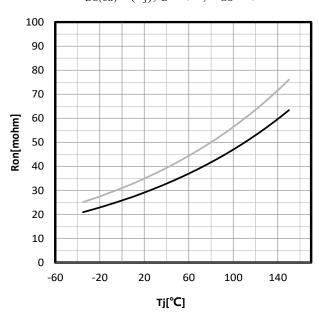
Typ. transfer characteristics $I_D\!\!=\!\!f(V_{\rm GS})$



Typ. drain-source on resistance

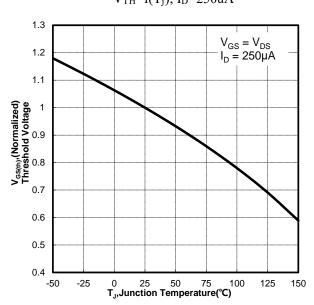


 $\begin{array}{l} \textbf{Drain-source on-state resistance} \\ R_{DS(on)} \!\!=\!\! f(T_j); \! I_D \!\!=\!\! 10A; \, V_{GS} \!\!=\!\! 10V \end{array}$

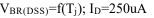


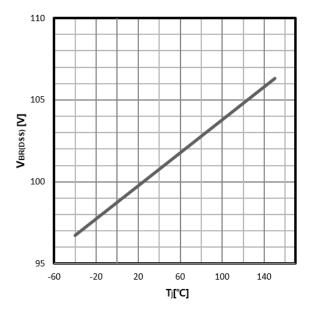


 $\begin{array}{l} \textbf{Gate Threshold Voltage} \\ V_{TH} \!\!=\!\! f(T_j); \ I_D \!\!=\!\! 250 uA \end{array}$

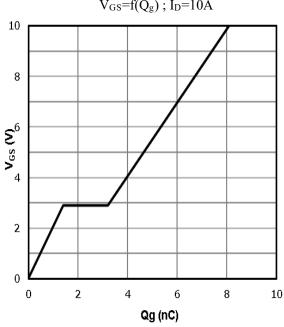


 $\begin{array}{c} \textbf{Drain-source breakdown voltage} \\ V_{BR(DSS)} \!\!=\!\! f(T_j); \, I_D \!\!=\!\! 250 uA \end{array}$

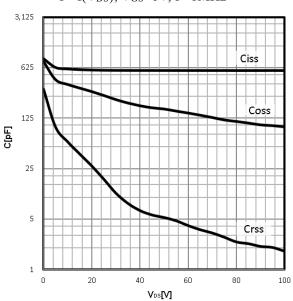




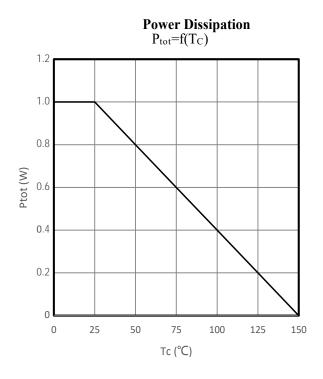
 $\begin{array}{l} \textbf{Typ. gate charge} \\ V_{GS} = & f(Q_g) \; ; \; I_D = 10A \end{array}$

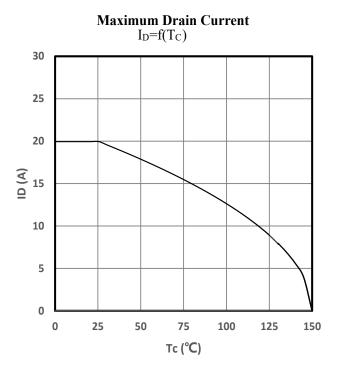


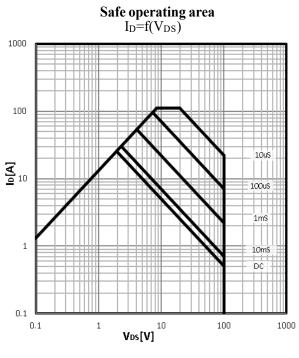
$$\label{eq:condition} \begin{split} & \textbf{Typ. capacitances} \\ & C = & f(V_{DS}); \ V_{GS} = & 0V; \ f = & 1MHz \end{split}$$

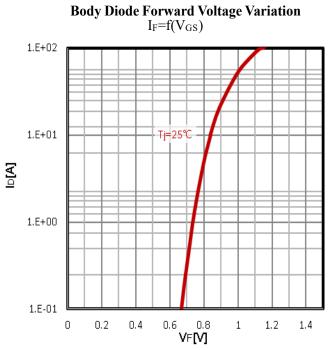






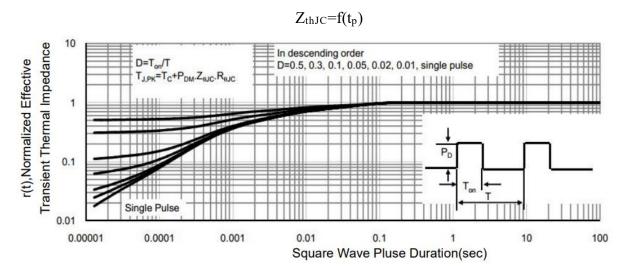






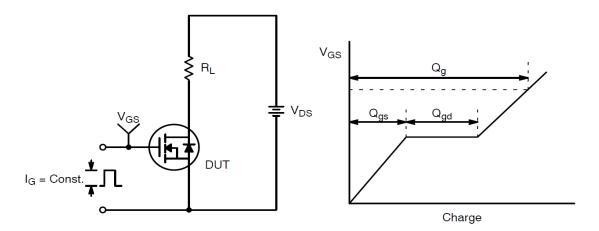


Max. transient thermal impedance

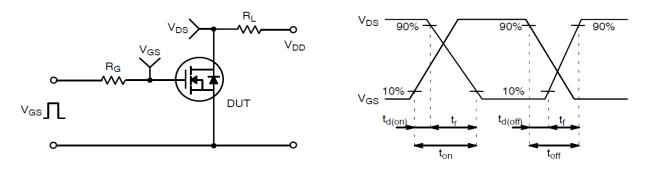




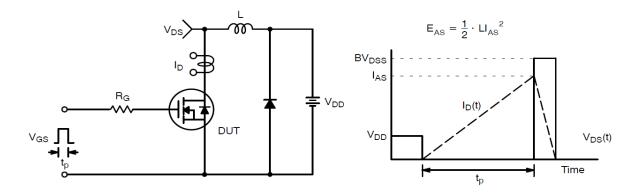
Test Circuit and Waveform:



Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

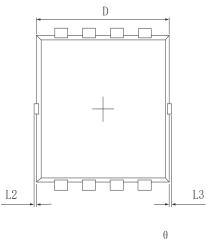


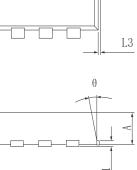
Unclamped Inductive Switching Test Circuit & Waveforms

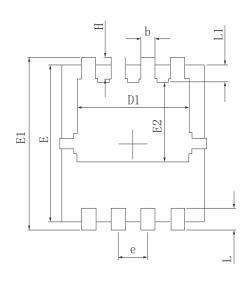


A2

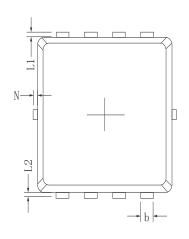
•Dimensions (PDFN3.3*3.3)

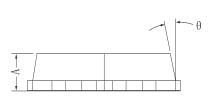


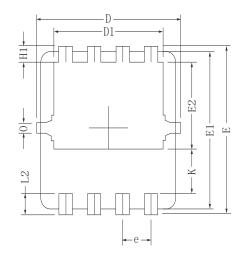


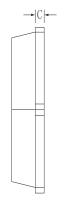


CVMDOI	MILLIMETER			
SYMBOL	MIN	Тур.	MAX	
A	0.700	0.800	0.900	
A1	0.	152REF	ì.	
A2		0~0.05		
D	3.000	3. 100	3.200	
D1	2.300	2. 450	2.600	
Е	2.900	3.000	3. 100	
E1	3. 150	3. 300	3.450	
E2	1.320	1. 520	1.720	
b	0.200	0.300	0.400	
е	0.550	0.650	0.750	
L	0.300	0.400	0.500	
L1	0.180	0.330	0.480	
L2	0~0.100			
L3	0~0.100			
Н	0.315	0.415	0.515	
θ	8°	10°	12°	





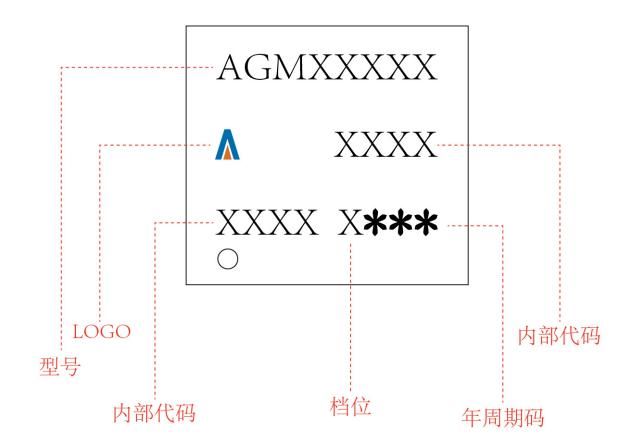




C 1 1	Millimeters			
Symbols	MIN.	NOM.	MAX.	
A	0.65	0.75	0.85	
b	0.25	0.30	0.35	
С	0.15	0.20	0.25	
D	3.00	3. 10	3.20	
D1	2.40	2.50	2.60	
Е	3. 20	3. 30	3.40	
E1	3.00	3. 10	3.20	
E2	1.60	1.70	1.80	
е	0. 65 BSC.			
H1	0.21	0.31	0.41	
Н2	0.30	0.40	0.50	
K	0.78	0.88	0.98	
L1/L2	0.10 REF.			
θ	11°	12°	13°	
N	0	-	0.15	
0	0.2 REF.			



PDFN3.3*3.3 Marking Instructions:





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